

Notice of References Cited	Application/Control No. 10/750,141	Applicant(s)/Patent Under Reexamination YAMAKAWA ET AL.	
	Examiner Rebecca M. Stadler	Art Unit 1754	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,866,801	03-2005	Mau et al.	264/29.1
*	B	US-2004/0072994	04-2004	Herr et al.	530/350
*	C	US-6,401,526	06-2002	Dai et al.	73/105
*	D	US-6,696,022	02-2004	Chan et al.	422/99
*	E	US-6,159,742	12-2000	Lieber et al.	436/164
*	F	US-2003/0132121	07-2003	Breen et al.	205/231
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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